

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2829 Examiner: J. Hollington

AMENDMENT

AFTER FINAL

April 10, 2003

In Re NEW PATENT APPLICATION Of:

Applicant: Miki

Mikio OHTAKI

Appln. No.:

09/904,663

Filed:

July 16, 2001

For:

METHOD FOR MANUFACTURING

AND BATCH TESTING

SEMICONDUCTOR DEVICES

(As Amended)

Atty Ref.:

KAN 120D1

Commissioner for Patents Washington, D.C. 20231 **BOX - AF**

Sir:

Responsive to the Examiner's Action dated December 10, 2002, a Petition for a One-Month Extension of Time being submitted herewith, please amend the application as follows:

IN THE SPECIFICATION

Please replace the title on page 1 of the Specification with the following:

--METHOD FOR MANUFACTURING AND BATCH TESTING

SEMICONDUCTOR DEVICES --

FEE ENCLOSED:\$ 1/0\
Pleaca charge any further
fee to our Deposit Account
No. 10-9992

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